



Sheet 1 of 2

Form PTO-144 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 122698		APPLICATION NO. 10/523,921	
INFORMATION DISCLOSURE STATEMENT							
(Use several sheets if necessary)							
				APPLICANT(S) Hidetoshi KUSUMI			
				FILING DATE February 7, 2005		GROUP 2834	
U.S. PATENT DOCUMENTS							
Examiner Initials	Cite No.	Document Number	Date	Name			
	1	US 5,694,313	12/2/1997	Ooiwa			
	2	US 5,705,902	01/6/1998	Merritt et al.			
	3	US 6,002,219	12/14/1999	Permuy			
	4	US 6,713,888-B2	03/30/2004	Kajiura			
	5	US 6,725,821-B2	04/27/2004	Warren et al.			
	6	US 6,806,671-B2	10/19/2004	Kusaka et al.			
	7	US 6,882,047-B2	04/19/2005	Hata et al.			
	8	US 2006/0087181-A1	04/27/2006	Kusumi			
	9	US 6,538,352-B2	03/25/2003	Asao			
FOREIGN PATENT DOCUMENTS							
Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation	
	10	JP-A-06-062553	03/04/1994	JAPAN	X	X	
	11	JP-U-03-111184	11/14/1991	JAPAN	X		
	12	JP-A-56-081069	07/02/1981	JAPAN	X		
	13	JP-A-04-011757	01/16/1992	JAPAN	X		
	14	JP-A-05-067889	03/19/1993	JAPAN	X	X	
	15	JP-A-2001-270401	10/02/2001	JAPAN	X	X	
	16	JP-A-2001-268924	09/28/2001	JAPAN	X	X	
	17	JP-A-11-235051	08/27/1999	JAPAN	X	X	
	18	JP-A-2002-153030	05/24/2002	JAPAN	X	X	
	19	JP-A-08-084439	03/26/1996	JAPAN	X	X	
OTHER DOCUMENTS							
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)					
EXAMINER						DATE CONSIDERED	
/Thanh Lam/ (03/26/2008)							
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Date: November 30, 2007

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Form PTO-1449 (REV. 1/06)	US Dept. of Commerce PATENT & TRADEMARK OFFICE	ATTY DOCKET NO. 122698	APPLICATION NO. 10/523,921
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)		APPLICANT(S) Hidetoshi KUSUMI	
		FILING DATE February 7, 2005	GROUP 2834

U.S. PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number	Date	Name

FOREIGN PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation
	20	JP-A-11-284122	10/15/1999	JAPAN	X	X
	21	JP-A-09-143649	06/03/1997	JAPAN	X	X
	22	JP-A-10-056762	02/24/1998	JAPAN	X	X
	23	JP-A-61-240666	10/25/1986	JAPAN	X	

OTHER DOCUMENTS

Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER	/Thanh Lam/ (03/26/2008)	DATE CONSIDERED
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